

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. ASMEX.270DV1C1	APPLICATION NO. 10/654,068
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT Jacobson et al.	
(USE SEVERAL SHEETS IF NECESSARY)		FILING DATE September 3, 2003	GROUP 1742

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NOV 19 2004
PATENT & TRADEMARK OFFICE

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES
<i>Sly</i>	1	JP 2889926	05/10/99	Japan	—	—	

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EXAMINER	<i>Shawn Lee Fugue</i>	DATE CONSIDERED	<i>2/5/05</i>
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.			

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DECEMBER 15 2003 U.S. PATENT AND TRADEMARK OFFICE (USE SEVERAL SHEETS IF NECESSARY)		
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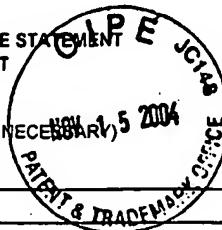
U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
SK	4,116,733	9/26/78	Olsen et al.			
	4,331,485	5/25/82	Gat			
	5,011,794	4/30/91	Grim et al.			
	5,080,549	1/14/92	Goodwin et al.			
	5,203,547	4/20/93	Marumo			
	5,834,322	11/10/98	Fusegawa et al.			
	5,997,588	12/7/99	Goodwin et al.			
	6,068,441	5/30/00	Raaijmakers et al.			
	6,072,157	6/6/00	Klebanoff et al.			
	6,111,225	8/29/00	Ohkase et al.			
	6,113,984	9/5/00	MacLeish et al.			
	6,136,725	10/24/00	Loan et al.			
	6,151,446	11/21/00	Hunter et al.			
	6,184,972	2/6/01	Mizutani et al.			
	6,183,183 B1	2/6/01	Goodwin et al.			
	6,191,399 B1	2/20/01	Van Bilsen			
	6,209,220 B1	4/3/01	Raaijmakers			
	6,242,718	6/5/01	Ferro et al.			
	6,290,491	9/18/01	Shahvandi et al.			
	6,306,183	10/23/01	Fujita et al.			
	6,344,084	2/5/02	Koinuma et al.			
SK	6,413,321	7/2/02	Kim et al.			
SK	6,483,081	11/19/02	Batchelder			

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EXAMINER Initials	Shaunna Fugue	DATE CONSIDERED 2/5/05
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
<i>Stef</i>	1	5,226,056	06/07/93	Kikuchi et al.	—	—	
<i>Stef</i>	2	2001/047979 A1	06/12/01	Wang et al.	—	—	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
					YES	NO	
<i>Stef</i>	3	JP 03135011	10/06/91	Japan	—	—	

OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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